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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

⊡XFI

Details	
Product Status	Active
Core Processor	RL78
Core Size	16-Bit
Speed	20MHz
Connectivity	CSI, I ² C, LINbus, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	6
Program Memory Size	2KB (2K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	256 x 8
Voltage - Supply (Vcc/Vdd)	2V ~ 5.5V
Data Converters	A/D 4x8/10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	10-LSSOP (0.173", 4.40mm Width)
Supplier Device Package	10-LSSOP
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f10y16dsp-30

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

1.4 Pin Identification

ANI0 to ANI6	: Analog Input
INTP0 to INTP3	: Interrupt Request From Peripheral
KR0 to KR5	: Key Return
P00 to P07	: Port 0
P40, P41	: Port 4
P121, P122, P125	: Port 12
P137	: Port 13
PCLBUZ0	: Programmable Clock Output/ Buzzer Output
EXCLK	: External Clock Input
X1, X2	: Crystal Oscillator (Main System Clock)
IVCMP0	: Comparator Input
VCOUT0	: Comparator Output
IVREF0	: Comparator Reference Input
RESET	: Reset
RxD0	: Receive Data
SCK00, SCK01	: Serial Clock Input/Output
SCL00, SCLA0	: Serial Clock Output
SDA00, SDAA0	: Serial Data Input/Output
SI00, SI01	: Serial Data Input
SO00, SO01	: Serial Data Output
TI00 to TI03	: Timer Input
TO00 to TO03	: Timer Output
TOOL0	: Data Input/Output for Tool
TxD0	: Transmit Data
Vdd	: Power Supply
Vss	: Ground



1.6 Outline of Functions

This outline describes the function at the time when Peripheral I/O redirection register (PIOR) is set to 00H.

Item			10-pin			16-pin		
		R5F10Y14	R5F10Y16	R5F10Y17	R5F10Y44	R5F10Y46	R5F10Y47	
Code flash	memory	1 KB	2 KB	4 KB	1 KB	2 KB	4 KB	
RAM		128 B	256 B	512 B	128 B	256 B	512 B	
Main system clock	High-speed system clock	_			main system of 1 to 20 MHz: 1	al/ceramic) oscilla clock input (EXCL VDD = 2.7 to 5.5 V DD = 2.0 to 5.5 V	K): /	
	High-speed on-chip	• 1.25 to 20	MHz (Vdd = 2.7	to 5.5 V)				
	oscillator clock		1Hz (Vod = 2.0 to	,				
Low-speed clock	on-chip oscillator	15 kHz (TYP)						
	urpose register	8-bit register	× 8					
	nstruction execution		/Hz operation)					
Instruction	set	MultiplicationRotate, bar	subtractor/logication (8 bits \times 8 bits rrel shift, and bit					
I/O port	Total	8	,		14			
	CMOS I/O	6 (N-ch open	-drain output (Vi	op tolerance): 2)	10 (N-ch oper	n-drain output (VD	D tolerance): 4	
	CMOS input	2		, , ,	4	• •	,	
Timer	16-bit timer	2 channels			4 channels			
	Watchdog timer	1 channel						
	12-bit interval timer	_			1 channel			
	Timer output	2 channels (PWM output: 1) 4 channels (PWM outputs: 3 Note 1)					^{te 1})	
Clock outp	ut/buzzer output	1						
		2.44 kHz to 1	0 MHz: (Periphe	eral hardware cloo	ck: fmain = 20 MHz	operation)		
Comparate	or	—			1			
8-/10-bit re	esolution A/D converter	4 channels			7 channels			
Serial inte	face	[10-pin products] CSI: 1 channel/simplified I ² C: 1 channel/UART: 1 channel						
		[16-pin produ	icts] CSI: 2 chan	nels/simplified I20	C: 1 channel/UAR	T: 1 channel		
	I ² C bus	—			1 channel			
Vectored	Internal	8			14			
interrupt sources	External	3			5			
Key interru	ıpt	6						
Reset		Reset by R	RESET pin					
		Internal reset by watchdog timer						
		Internal reset by selectable power-on-reset						
		Internal reset by illegal instruction execution Note 2						
				tion lower limit vo	oltage			
Selectable	power-on-reset circuit	Detection v	-					
				//2.68 V/3.02 V/4.				
		Falling edge (Vspdr): 2.20 V/2.62 V/2.96 V/4.37 V (max.)						



Item	10-pin			16-pin				
	R5F10Y14	R5F10Y16	R5F10Y17	R5F10Y44	R5F10Y46	R5F10Y47		
On-chip debug function	Provided	Provided						
Power supply voltage	VDD = 2.0 to 5	.5 V ^{Note 3}						
Operating ambient temperature	TA = - 40 to + 85 °C							

Notes 1. The number of outputs varies, depending on the setting of channels in use and the number of the master (see **6.9.4 Operation as multiple PWM output function** in the RL78/G10 User's Manual).

2. The illegal instruction is generated when instruction code FFH is executed. Reset by the illegal instruction execution not issued by emulation with the on-chip debug emulator.

3. Use this product within the voltage range from 2.25 to 5.5 V because the detection voltage (VSPOR) of the selectable power-on-reset (SPOR) circuit should also be considered.



2. ELECTRICAL SPECIFICATIONS

- Cautions 1. The RL78 microcontrollers have an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.
 - 2. The pins mounted depend on the product. Refer to 2.1 Port Functions and 2.2.1 Functions for each product in the RL78/G10 User's Manual.
 - 3. Use this product within the voltage range from 2.25 to 5.5 V because the detection voltage (VSPOR) of the selectable power-on-reset (SPOR) circuit should also be considered.



2.1 Absolute Maximum Ratings

(T_A = 25°C)

Parameter	Symbols	Co	onditions	Ratings	Unit
Supply Voltage	VDD			–0.5 to +6.5	V
Input Voltage	VI1			-0.3 to V _{DD} + 0.3 ^{Note}	V
Output Voltage	V ₀₁			-0.3 to V _{DD} + 0.3	V
Output current, high	Іон1	Per pin		-40	mA
		Total of all pins	P40, P41	-70	mA
			P00 to P07	-100	mA
Output current, low	IOL1	Per pin		40	mA
		Total of all pins	P40, P41	70	mA
			P00 to P07	100	mA
Operating ambient temperature	TA			-40 to +85	°C
Storage temperature	Tstg			-65 to +150	°C

Note Must be 6.5 V or lower.

- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remarks 1.** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

2. The reference voltage is Vss.



2.2 Oscillator Characteristics

2.2.1 X1 oscillator characteristics

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

Parameter	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock	Ceramic resonator/	$2.7~V \leq V_{\text{DD}} \leq 5.5~V$	1		20	MHz
oscillation frequency (fx) ^{Note}	crystal resonator	$2.0 \text{ V} \le \text{V}_{\text{DD}} < 2.7 \text{ V}$	1		5	MHz

- **Note** Indicates only permissible oscillator frequency ranges. Refer to AC Characteristics for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.
- Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.
- Remark When using the X1 oscillator, refer to 5.4 System Clock Oscillator in the RL78/G10 User's Manual.

2.2.2 On-chip oscillator characteristics

$(1A = -40\ 10\ 405\ 0,\ 2.0\ V \le VDD \le 5.5)$	v , v ₃₃ = v v					
Oscillators	Parameters	Conditions	MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator oscillation clock frequency Notes 1, 2	fін		1.25		20	MHz
High-speed on-chip oscillator oscillation		TA = -20 to +85°C	-2.0		+2.0	%
clock frequency accuracy		TA = -40 to -20°C	-3.0		+3.0	%
Low-speed on-chip oscillator oscillation clock frequency	fı∟			15		kHz
Low-speed on-chip oscillator oscillation clock frequency accuracy			-15		+15	%

Notes 1. High-speed on-chip oscillator frequency is selected by bits 0 to 2 of option byte (000C2H).

2. This only indicates the oscillator characteristics. Refer to AC Characteristics for instruction execution time.



(1/2)

2.3 DC Characteristics

2.3.1 Pin characteristics

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

TA = -40 10 + 65 C,	2.0 V 5	$VDD \leq 5.5 V, Vss = 0 V)$					(1/2)
Parameter	Symbol	Conditions	Conditions				Unit
Output current, high Note 1	Іон1	Per pin for 10-pin products: P00 to P04, P40 16-pin products: P00 to P07, P40, P41				-10.0 Note 2	mA
	Total of 10-pin products: P40 16-pin products: P40, P41	10-pin products: P40	$\begin{array}{c} 4.0 \ V \leq V_{DD} \leq 5.5 \ V \\ \hline 2.7 \ V \leq V_{DD} < 4.0 \ V \\ \hline 2.0 \ V \leq V_{DD} < 2.7 \ V \end{array}$			-20.0 -4.0 -3.0	mA mA mA
		(When duty ≤ 70% ^{Note 3}) Total of 10-pin products: P00 to P04	$4.0 V \le V_{DD} \le 5.5 V$ $2.7 V \le V_{DD} < 4.0 V$			-60.0 -12.0	mA
		16-pin products: P00 to P07 (When duty \leq 70% ^{Note 3})	$2.0~V \leq V_{\text{DD}} < 2.7~V$			-9.0	mA
Output current, low Note 4	IOL1	Total of all pins (When duty ≤ 70% ^{Note 3}) Per pin for 10-pin products: P00 to P04, P40 16-pin products: P00 to P07, P40, P41				-80.0 20.0 Note 2	mA mA
	Total of 10-pin products: P40 16-pin products: P40, P41 (When duty $\leq 70\%$ ^{Note 3}) Total of 10-pin products: P00 to P04 16-pin products: P00 to P07 (When duty $\leq 70\%$ ^{Note 3})	10-pin products: P40 16-pin products: P40, P41				40.0 6.0 1.2	mA mA mA
		10-pin products: P00 to P04	$\begin{array}{l} 4.0 \ V \leq V_{DD} \leq 5.5 \ V \\ \hline 2.7 \ V \leq V_{DD} < 4.0 \ V \\ \hline 2.0 \ V \leq V_{DD} < 2.7 \ V \end{array}$			80.0 12.0 2.4	mA mA mA
		Total of all pins (When duty $\leq 70\%$ ^{Note 3})	Total of all pins (When duty $\leq 70\%$ Note ³)			120.0	mA

Notes 1. Value of current at which the device operation is guaranteed even if the current flows from the V_{DD} pin to an output pin.

- 2. Do not exceed the total current value.
- 3. This is the output current value under conditions where the duty factor ≤ 70%. The output current value when the duty factor > 70% can be calculated with the following expression (when changing the duty factor to n%).
 - Total output current of pins = (I_{OH} × 0.7)/(n × 0.01)
 <Example> Where n = 80 % and I_{OH} = 10.0 mA
 Total output current of pins = (- 10.0 × 0.7)/(80 × 0.01) ≅ 8.7 mA
 - Total output current of pins = (IoL × 0.7)/(n × 0.01) <Example> Where n = 80 % and IoL = 10.0 mA

Total output current of pins = $(10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

4. Value of current at which the device operation is guaranteed even if the current flows from an output pin to the Vss pin.

Caution P00, P01, P06, and P07 do not output high level in N-ch open-drain mode.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port.

2.3.2 Supply current characteristics

(1) Flash ROM: 1 and 2 KB of 10-pin products

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{ Vss} = 0 \text{ V})$

Parameter	Symbol			Conditions		MIN.	TYP.	MAX.	Unit
Supply current	Idd1	Operating mode	Basic operation	f⊪ = 20 MHz	V _{DD} = 3.0 V, 5.0 V		0.91		mA
			Normal	f _{IH} = 20 MHz	V _{DD} = 3.0 V, 5.0 V		1.57	2.04	
			operation	f⊪ = 5 MHz	V _{DD} = 3.0 V, 5.0 V		0.85	1.15	
	DD2 ^{Note 2}	HALT mode)	fiH = 20 MHz	V _{DD} = 3.0 V, 5.0 V		350	820	μA
				fін = 5 MHz	V _{DD} = 3.0 V, 5.0 V		290	600	
	DD3 ^{Note 3}	STOP mode	e	V _{DD} = 3.0 V	•		0.56	2.00	μA

Notes 1. Total current flowing into V_{DD}, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, I/O port, and on-chip pull-up/pull-down resistors.

- 2. During HALT instruction execution by flash memory.
- 3. Not including the current flowing into the watchdog timer.
- Remarks 1. fin: High-speed on-chip oscillator clock frequency
 - **2.** Temperature condition of the typical value is $T_A = 25^{\circ}C$



(3) Peripheral Functions (Common to all products)

Parameter	Symbol		Conditions	MIN.	TYP.	MAX.	Unit
Low-speed on- chip oscillator operating current	_{FIL} Note 1				0.30		μΑ
12-bit interval timer operating current	ТМКА Notes 1, 2, 3				0.01		μA
Watchdog timer operating current	WDT Notes 1, 4				0.01		μΑ
A/D converter operating current	IADC Notes 1, 5	When conversion at maximum speed	V _{DD} = 5.0 V V _{DD} = 3.0 V		1.30 0.50	1.90	mA mA
Comparator operating	ICMP Notes 1, 6	In high-speed mode	V _{DD} = 5.0 V		6.50		μA
current		In low-speed mode	V _{DD} = 5.0 V		1.70		μA
Internal reference voltage operating current	IVREG Note 1				10		μΑ

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{ V}_{SS} = 0 \text{ V})$

Notes 1. Current flowing to VDD.

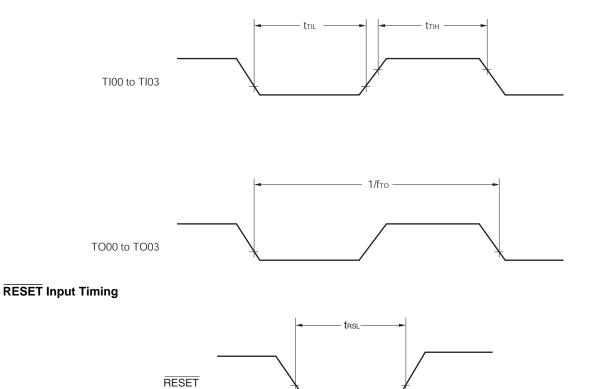
- 2. When high speed on-chip oscillator and high-speed system clock are stopped.
- 3. Current flowing only to the 12-bit interval timer (excluding the operating current of the low-speed on-chip oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1, IDD2 or IDD3 and IFIL and ITMKA, when the 12-bit interval timer is in operation.
- 4. Current flowing only to the watchdog timer (excluding the operating current of the low-speed on-chip oscillator). The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and IFIL and IWDT when the watchdog timer is in operation.
- 5. Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC when the A/D converter operates in an operation mode or the HALT mode.
- 6. Current flowing only to the comparator. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ICMP when the comparator is in operation.

Remarks 1. fil: Low-speed on-chip oscillator clock frequency

2. Temperature condition of the typical value is $T_A = 25^{\circ}C$



TI/TO Timing





Parameter	Symbol	(Conditions	MIN.	TYP.	MAX.	Unit
SCKp cycle time	tkCY1	tксү1 ≥ 4/fc∟к	$2.7~V \leq V_{\text{DD}} \leq 5.5~V$	200			ns
			$2.0~V \leq V_{\text{DD}} \leq 5.5~V$	800			ns
SCKp high-/low-level width	t кн1, t к∟1	$2.7 \text{ V} \leq V_{\text{DD}} \leq 5.5 \text{ V}$		tkcy1/2 - 18			ns
		$2.0~V \leq V_{\text{DD}} \leq 5$	tkcy1/2 - 50			ns	
SIp setup time (to SCKp↑) Note 1	tsik1	$2.7 \text{ V} \leq V_{\text{DD}} \leq 5$.5 V	47			ns
		$2.0~V \le V_{\text{DD}} \le 5$	$2.0~V \leq V_{\text{DD}} \leq 5.5~V$				ns
SIp hold time (from SCKp↑) ^{Note 1}	tksi1			19			ns
Delay time from SCKp↓ to SOp output ^{Note 2}	tkso1	C = 30 pF ^{Note 3}				25	ns

(2) CSI mode (master mode, SCKp... internal clock output)

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

Notes 1. When DAP0n = 0 and CKP0n = 0, or DAP0n = 1 and CKP0n = 1. The SIp setup time becomes "to SCKp↓" and SIp hold time becomes "from SCKp↓" when DAP0n = 0 and CKP0n = 1, or DAP0n = 1 and CKP0n = 0.

2. When DAP0n = 0 and CKP0n = 0, or DAP0n = 1 and CKP0n = 1. The delay time to SOp output becomes "from SCKp[↑]" when DAP0n = 0 and CKP0n = 1, or DAP0n = 1 and CKP0n = 0.

3. C is the load capacitance of the SCKp and SOp output lines.

(3) CSI mode (slave mode, SCKp... external clock input)

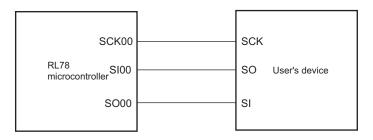
Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit	
SCKp cycle time	t ксү2	$2.7~V \le V_{\text{DD}} \le 5.5$	V fmcr	< > 16 MHz	8/fмск			ns
			fмск	< ≤ 16 MHz	6/fмск			ns
		$2.0~V \le V_{\text{DD}} \le 5.5$	V		6/fмск			ns
SCKp high-/low-level width	t кн2,	$2.0 \text{ V} \leq V_{\text{DD}} \leq 5.5$	V		tксү2/2 - 18			ns
	tĸ∟2							
SIp setup time (to SCKp↑) ^{Note 1}	tsik2	$2.7~V \le V_{\text{DD}} \le 5.5$	V		1/fмск+ 20			ns
		$2.0 \text{ V} \leq V_{\text{DD}} \leq 5.5$	V		1/fмск+ 30			ns
SIp hold time (from SCKp^) $^{\rm Note \ 1}$	tksi2	$2.0 \text{ V} \le \text{V}_{\text{DD}} \le 5.5$	V		1/fмск+ 31			ns
Delay time from SCKp \downarrow to SOp	tkso2	C = 30 pF Note 3	2.7 V ≤ \	$V_{DD} \le 5.5 \text{ V}$			2/fмск+50	ns
output Note 2			2.0 V ≤ \	$V_{DD} \le 5.5 \text{ V}$			2/fмск+110	ns

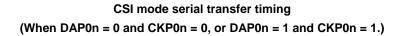
$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{ V}_{SS} = 0 \text{ V})$

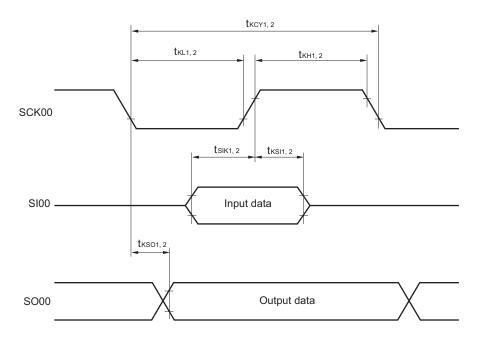
- Notes 1. When DAP0n = 0 and CKP0n = 0, or DAP0n = 1 and CKP0n = 1. The SIp setup time becomes "to SCKp↓" and the SIp hold time becomes "from SCKp↓" when DAP0n = 0 and CKP0n = 1, or DAP0n = 1 and CKP0n = 0.
 - 2. When DAP0n = 0 and CKP0n = 0, or DAP0n = 1 and CKP0n = 1. The delay time to SOp output becomes "from SCKp[↑]" when DAP0n = 0 and CKP0n = 1, or DAP0n = 1 and CKP0n = 0.
 - 3. C is the load capacitance of the SOp output lines.

Remarks 1. p: CSI number (p = 00, 01), n: Channel number (n = 0, 1)

 fMCK: Serial array unit operation clock frequency (Operation clock to be set by the serial clock select register 0 (SPS0) and the CKS0n bit of the serial mode register 0nH (SMR0nH). n: Channel number (n = 0, 1)) CSI mode connection diagram







Remark p: CSI number (p = 00, 01), n: Channel number (n = 0, 1)



2.5.2 Serial interface IICA

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.0 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{ V}_{SS} = 0 \text{ V})$

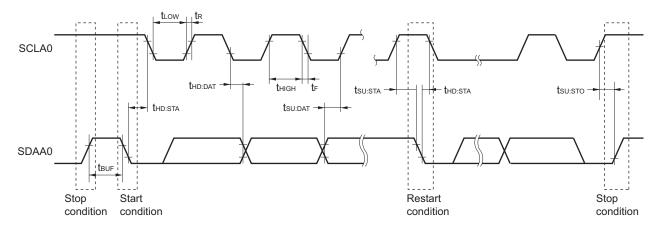
Parameter	Symbol	Conditions	Standa	rd Mode	Fast	Mode	Unit
			MIN.	MAX.	MIN.	MAX.	
SCLA0 clock frequency	fsc∟	Fast mode: $f_{CLK} \ge 3.5 \text{ MHz}$			0	400	kHz
		Standard mode: $f_{CLK} \ge 1 \text{ MHz}$	0	100			kHz
Setup time of restart condition	tsu:sta		4.7		0.6		μs
Hold time ^{Note 1}	thd:sta		4.0		0.6		μs
Hold time when SCLA0 = "L"	tLOW		4.7		1.3		μs
Hold time when SCLA0 = "H"	tніgн		4.0		0.6		μs
Data setup time (reception)	tsu:dat		250		100		ns
Data hold time (transmission)Note 2	thd:dat		0	3.45	0	0.9	μs
Setup time of stop condition	tsu:sto		4.0		0.6		μs
Bus-free time	t BUF		4.7		1.3		μs

Notes 1. The first clock pulse is generated after this period when the start/restart condition is detected.

- 2. The maximum value (MAX.) of the:DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.
- **Remark** The maximum value of Cb (communication line capacitance) and the value of Rb (communication line pull-up resistor) at that time in each mode are as follows.

 $\begin{array}{lll} \mbox{Standard mode:} & C_b = 400 \mbox{ pF}, \mbox{ } R_b = 2.7 \mbox{ } k\Omega \\ \mbox{Fast mode:} & C_b = 200 \mbox{ } pF, \mbox{ } R_b = 1.7 \mbox{ } k\Omega \\ \end{array}$

IICA serial transfer timing





2.8 Flash Memory Programming Characteristics

$(T_A = 0 \text{ to } + 40^{\circ}C, 4.5 \text{ V} \le V_{DD} \le 5.5 \text{ V}, \text{ Vss} = 0 \text{ V})$

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Code flash memory rewritable times Notes 1, 2, 3	Cerwr	Retained for 20 years.	T _A = +85°C	1000			Times

- **Notes 1.** 1 erase + 1 write after the erase is regarded as 1 rewrite. The retaining years are until next rewrite after the rewrite.
 - 2. When using flash memory programmer.
 - **3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.

2.9 Dedicated Flash Memory Programmer Communication (UART)

 $(T_A = 0 \text{ to } + 40^{\circ}\text{C}, 4.5 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

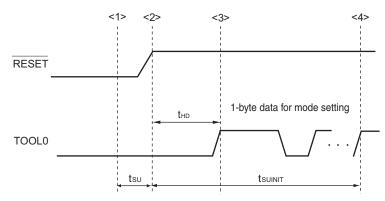
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate				115,200		bps

Remark The transfer rate during flash memory programming is fixed to 115,200 bps.



2.10 Timing of Entry to Flash Memory Programming Modes

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Time to complete the communication for the initial setting after the external reset is released	tsuinit	SPOR reset must be released before the external reset is released.			100	ms
Time to release the external reset after the TOOL0 pin is set to the low level	tsu	SPOR reset must be released before the external reset is released.	10			μs
Time to hold the TOOL0 pin at the low level after the external reset is released	tнo	SPOR reset must be released before the external reset is released.	1			ms



- <1> The low level is input to the TOOL0 pin.
- <2> The external reset is released (SPOR reset must be released before the external reset is released.).
- <3> The TOOL0 pin is set to the high level.
- <4> Setting of entry to the flash memory programming mode by UART reception is completed.
- **Remark** tsuinit: Communication for the initial setting must be completed within 100 ms after the external reset is released during this period.
 - $t_{\text{SU:}}$ Time to release the external reset after the TOOL0 pin is set to the low level
 - thd: Time to hold the TOOL0 pin at the low level after the external reset is released



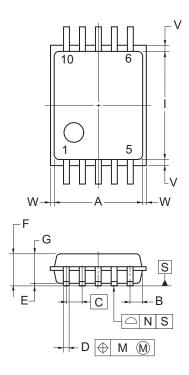
3. PACKAGE DRAWINGS

3.1 10-pin products

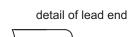
<R>

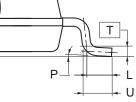
R5F10Y17ASP, R5F10Y16ASP, R5F10Y14ASP R5F10Y17DSP, R5F10Y16DSP, R5F10Y14DSP

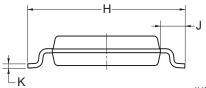
JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LSSOP10-4.4x3.6-0.65	PLSP0010JA-A	P10MA-65-CAC-2	0.05



Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material







(UNIT:mm)

ITEM	DIMENSIONS
А	3.60±0.10
В	0.50
С	0.65 (T.P.)
D	0.24 ± 0.08
E	0.10 ± 0.05
F	1.45 MAX.
G	1.20 ± 0.10
Н	6.40 ± 0.20
I	4.40±0.10
J	1.00 ± 0.20
К	$0.17^{+0.08}_{-0.07}$
L	0.50
М	0.13
N	0.10
Р	$3^{\circ}{+5^{\circ}}_{-3^{\circ}}$
Т	0.25 (T.P.)
U	0.60 ± 0.15
V	0.25 MAX.
W	0.15 MAX.

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NOTE

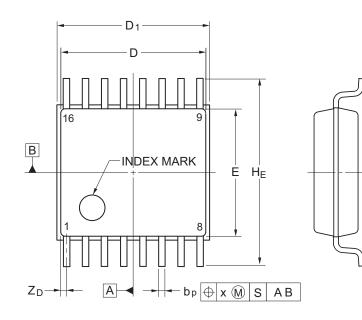
condition.

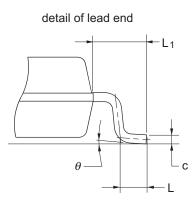


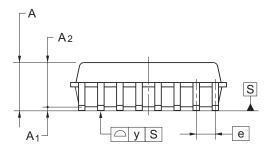
3.2 16-pin products

R5F10Y47ASP, R5F10Y46ASP, R5F10Y44ASP<R>R5F10Y47DSP, R5F10Y46DSP, R5F10Y44DSP

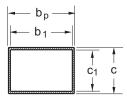
JEITA Package code	RENESAS code	Previous code	MASS(TYP.)[g]
P-SSOP16-4.4x5-0.65	PRSP0016JC-B	P16MA-65-FAB-1	0.08







Terminal cross section



Referance	Dimens	nsion in Millimeters			
Symbol	Min	Nom	Max		
D	4.85	5.00	5.15		
D ₁	5.05	5.20	5.35		
E	4.20	4.40	4.60		
A ₂		1.50			
A ₁	0.075	0.125	0.175		
А		_	1.725		
bp	0.17	0.24	0.32		
b ₁		0.22			
с	0.14	0.17	0.20		
C ₁		0.15			
θ	0°		8°		
HE	6.20	6.40	6.60		
е		0.65			
х			0.13		
У			0.10		
Z _D		0.225			
L	0.35	0.50	0.65		
L ₁		1.00			



Revision History

RL78/G10 Datasheet

			Description
Rev.	Date	Page	Summary
1.00	Apr 15, 2013	-	First Edition issued
2.00	Jan 10, 2014	1, 2	Modification of descriptions in 1.1 Features
		3	Modification of description in 1.2 List of Part Numbers
		4	Modification of remark 2 in 1.3.1 10-pin products and 1.3.2 16-pin products
		8, 9	Addition of description of R5F10Y17ASP in 1.6 Outline of Functions
		11	Modification of description in 2.1 Absolute Maximum Ratings
		12	Modification of description in 2.2 Oscillator Characteristics
		13, 14	Modification of description, notes 1 to 4, and caution in 2.3.1 Pin
		40	characteristics
		16	Addition of description, notes 1 to 6, and remarks 1 and 2 in (2) Flash ROM: 4 KB of 10-pin products, and 16-pin products
		17	Addition of description, notes 1 to 6, and remarks 1 to 3 in (3) Peripheral
		17	Functions (Common to all products)
		18	Modification of description in 2.4 AC Characteristics
		19	Addition of figure of Minimum Instruction Execution Time during Main System
		15	Clock Operation
		19	Addition of figure of External System Clock Timing
		20	Modification of TI/TO Timing
		25	Addition of description in 2.5.2 Serial interface IICA
		26	Modification of description and notes 1 to 6 in 2.6.1 A/D converter
			characteristics
		27	Addition of description, notes 1 and 2 in 2.6.2 Comparator characteristics
		27	Addition of description and note in 2.6.3 Internal reference voltage
			characteristics
		28	Addition of caution in 2.6.4 SPOR Circuit characteristics
		28	Addition of figure in 2.6.6 Data retention power supply voltage characteristics
		31	Addition of R5F10Y17ASP in 3.1 10-pin products
		32	Modification of package drawing in 3.2 16-pin products
3.00	Nov 19, 2014	3	Addition of industrial applications in Figure 1-1 Part Number, Memory Size, and Package of RL78/G10
		3	Addition of industrial applications in Table 1-1 List of Ordering Part Numbers
		4	Addition of description to pin configuration in 1.3.1 10-pin products and 1.3.2
		-	16-pin products
		22	Correction of error in 2.5.1 Serial array unit, (3) CSI mode (slave mode,
			SCKp external clock input)
		28	Renamed to 2.7 RAM Data Retention Characteristics and modification of figure
		31	Addition of industrial application in 3.1 10-pin products
		32	Addition of industrial application in 3.2 16-pin products and modification of
			package drawing
3.10	Aug 12, 2016	1	Addition of description to Rich Analog in 1.1 Features
		3	Corrected Table 1-1. List of Ordering Part Numbers
		4	Modification of 1.3 Pin Configuration (Top View)
		31, 32	Deletion of under development

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NOTES FOR CMOS DEVICES

- (1) VOLTAGE APPLICATION WAVEFORM AT INPUT PIN: Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between VIL (MAX) and VIH (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between VIL (MAX) and VIH (MIN).
- (2) HANDLING OF UNUSED INPUT PINS: Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.
- (3) PRECAUTION AGAINST ESD: A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.
- (4) STATUS BEFORE INITIALIZATION: Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.
- (5) POWER ON/OFF SEQUENCE: In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current. The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.
- (6) INPUT OF SIGNAL DURING POWER OFF STATE : Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

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